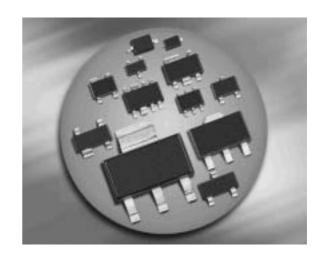


Silicon Low Leakage Diode

- Low-leakage applications
- Medium speed switching times
- Series pair configuration
- Pb-free (RoHS compliant) package 1)
- Qualified according AEC Q101







BAV199



Туре	Package	Configuration	Marking
BAV199	SOT23	series	JYs

Maximum Ratings at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Value	Unit	
Diode reverse voltage	V _R	80	V	
Peak reverse voltage	V _{RM}	85		
Forward current	/ _F	200	mA	
Non-repetitive peak surge forward current	I _{FSM}		А	
$t = 1 \mu s$		4.5		
t = 1 s		0.5		
Total power dissipation	P _{tot}	330	mW	
BAV199, <i>T</i> _S ≤ 31°C				
Junction temperature	T _j	150	°C	
Storage temperature	T _{stq}	-65 150		

Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ²⁾	R _{thJS}	≤ 360	K/W
BAV199			

1

¹Pb-containing package may be available upon special request

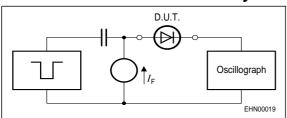
²For calculation of *R*_{thJA} please refer to Application Note Thermal Resistance



Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics		т.	T		
Breakdown voltage	$V_{(BR)}$	85	-	-	V
$I_{(BR)} = 100 \mu\text{A}$					
Reverse current	I _R				nA
$V_{R} = 75 \text{ V}$		-	-	5	
$V_{R} = 75 \text{ V}, T_{A} = 150 ^{\circ}\text{C}$		-	-	80	
Forward voltage	V_{F}				mV
$I_{F} = 1 \; mA$		-	-	900	
$I_{\rm F} = 10 \text{mA}$		-	-	1000	
$I_{\rm F} = 50 \text{mA}$		-	-	1100	
$I_{\rm F} = 150 \text{mA}$		-	-	1250	
AC Characteristics	,				•
Diode capacitance	C _T	-	2	-	pF
$V_{R} = 0 \text{ V}, f = 1 \text{ MHz}$					
Reverse recovery time	<i>t</i> _{rr}	-	0.6	1.5	μs
$I_{\rm F}$ = 10 mA, $I_{\rm R}$ = 10 mA, measured at $I_{\rm R}$ = 1mA ,					
$R_{\rm L}$ = 100 Ω					

Test circuit for reverse recovery time



Pulse generator: $t_p = 10\mu s$, D = 0.05, $t_r = 0.6ns$,

 $R_{\rm i} = 50\Omega$

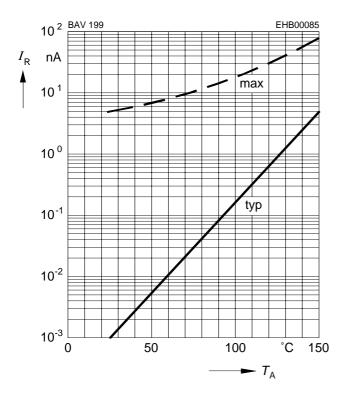
Oscillograph: $R = 50\Omega$, $t_{\rm f} = 0.35$ ns, $C \le 1$ pF

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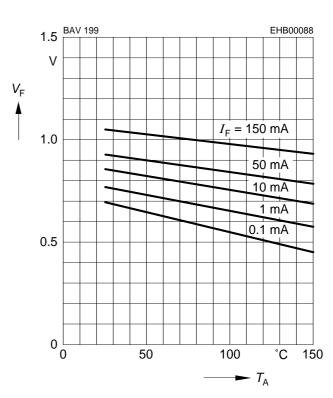
Reverse current $I_R = f(T_A)$

$$V_{R} = 70V$$



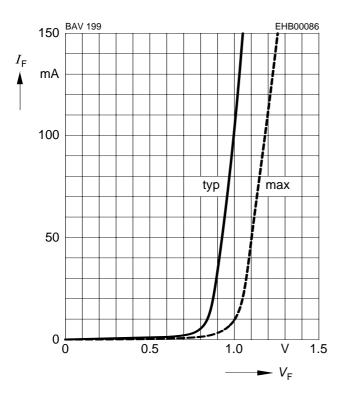
Forward Voltage $V_F = f(T_A)$

 $I_{\mathsf{F}} = \mathsf{Parameter}$



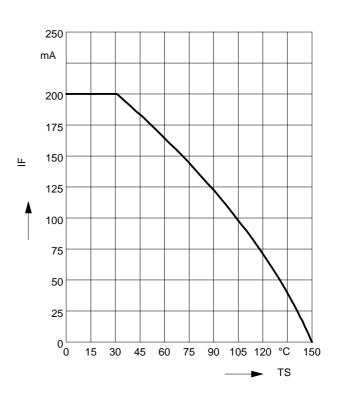
Forward current $I_F = f(V_F)$

$$T_{\mathsf{A}} = 25^{\circ}\mathsf{C}$$



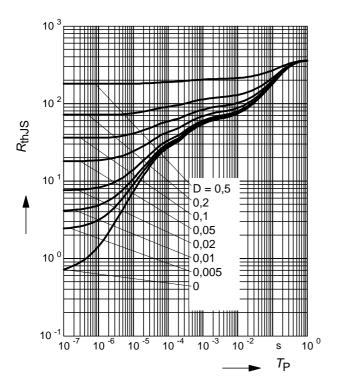
Forward current $I_F = f(T_S)$

BAV199



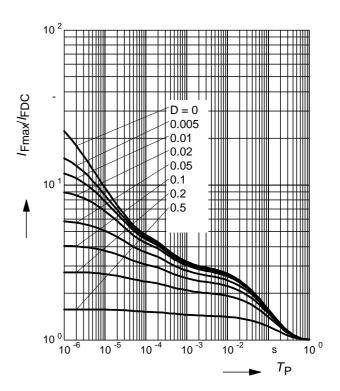


Permissible Puls Load $R_{thJS} = f(t_p)$



Permissible Pulse Load

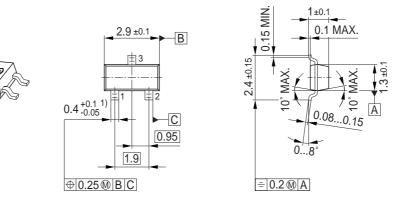
$$I_{\text{Fmax}}/I_{\text{FDC}} = f(t_{\text{p}})$$



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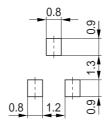


Package Outline

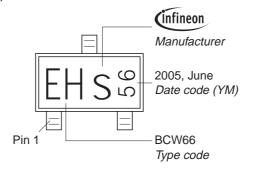


1) Lead width can be 0.6 max. in dambar area

Foot Print

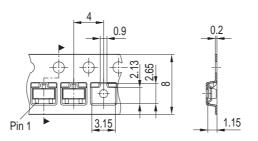


Marking Layout (Example)



Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel





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